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Atty.
Dkt. No.

M#

Client Ref.

0273961

P-0153.010-US

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Applicant: FINDERS et al.

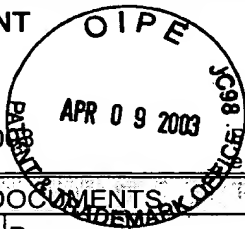
Appln. No.: 09/671,802

Filing Date: September 28, 2000

Examiner: Chacko Davis

Group Art Unit: 1756

Date: April 9, 2003



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of

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U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
	BR					
	CR					
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	IR					
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	KR					
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FOREIGN PATENT DOCUMENTS

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
WO	OR	WO 98/28665	07/1998	PCT	LOOPSTRA et al.				
WO	PR	WO 98/40791	09/1998	PCT	LOOPSTRA et al.				
WO	QR	WO 97/33205	09/1997	PCT	VAN DER WERF et al.				
WO	RR	EP 0 687 956 A1	05/1995	EPO	WANGLER et al.		X		X
	SR								
	TR								
	UR								

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

	VR								
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Examiner

Chacko Davis

Date Considered:

04/30/2003

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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Examiner's Initials*		Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
WD	AR	3,639,039	02/1972	RHODES, JR.	350	162SF	---
WD	BR	3,658,420	04/1972	AXELROD	356	71	---
WD	CR	3,492,635	01/1970	FARR	340	15.5	---
WD	DR	3,729,252	04/1973	NELSON	350	162	---
WD	ER	3,776,633	12/1973	FROSCH et al.	353	132	---
WD	FR	4,370,026	01/1983	DUBROEUCQ et al.	350	163	---
WD	GR	4,472,023	09/1984	YAMAMOTO	350	162.11	---
WD	HR	4,497,015	01/1985	KONNO et al.	362	248	---
WD	IR	4,619,508	10/1986	SHIBUYA et al.	353	1,225D	---
WD	JR	4,780,747	10/1988	SUZUKI et al.	355	683	---
WD	KR	4,789,222	12/1988	OTA et al.	350	167	---
WD	LR	4,814,829	03/1989	KOSUGI et al.	355	43	---
WD	MR	4,841,341	06/1989	OGAWA et al.	355	43	---
WD	NR	4,851,882	07/1989	TAKAHASHI et al.	355	46	---
WD	OR	4,854,669	08/1989	BIRNBACH et al.	350	162.12	---
WD	PR	4,939,630	07/1990	KIKUCHI et al.	362	268	---
WD	QR	4,947,413	08/1990	JEWELL et al.	378	34	---
WD	RR	4,970,546	11/1990	SUZUKI et al.	355	53	---
WD	SR	5,004,348	04/1991	MAGOME	356	401	---
WD	TR	5,153,773	10/1992	MURAKI et al.	359	619	---
WD	UR	5,191,374	03/1993	HAZAMA et al.	355	43	---
WD	VR	5,337,097	08/1994	SUZUKI et al.	353	101	---

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WR				Enclosed	No

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

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Group Art Unit: 1756

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Examiner's Initials*		Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
<i>WLD</i>	AR	6,084,655	07/2000	SUZUKI et al.	355	53	—
<i>WLD</i>	BR	6,128,068	10/2000	SUZUKI et al.	355	53	—
<i>WLD</i>	CR	6,271,909	08/2001	SUZUKI et al.	355	53	—
<i>WLD</i>	DR	2001/0007495	07/2001	SUZUKI et al.	355	53	—
<i>WLD</i>	ER	2001/0015797	08/2001	SUZUKI et al.	355	53	—
<i>WLD</i>	FR	6,252,647	06/2001	SHIRAISHI	355	53	—
<i>WLD</i>	GR	6,211,944	04/2001	SHIRAISHI	355	53	—
<i>WLD</i>	HR	6,233,041	05/2001	SHIRAISHI	355	53	—
<i>WLD</i>	IR	6,016,187	01/2000	NOGUCHI et al.	355	53	—
<i>WLD</i>	JR	5,742,376	04/1998	MAKINOCHI	355	53	—
<i>WLD</i>	KR	5,675,401	10/1997	WANGLER et al.	355	67	—
<i>WLD</i>	LR	5,712,698	01/1998	POSCHENRIEDER	355	46	—
<i>WLD</i>	MR	5,517,279	05/1996	HUGLE et al.	355	46	—
<i>WLD</i>	NR	5,659,409	08/1997	OOI et al.	349	10	—
<i>WLD</i>	OR	6,285,443	09/2001	WANGLER et al.	355	67	—
<i>WLD</i>	PR	6,259,512	07/2001	MIZOUCHI	355	67	—
<i>WLD</i>	QR	6,285,855	09/2001	TSUJI	399	618	—
<i>WLD</i>	RR	4,988,188	01/1991	OHTA	353	122	—
<i>WLD</i>	SR	6,049,374	01/2000	KOMATSUDA	355	67	—

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Deborah L. Davis

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Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
ND	AR 4,931,830	06/1990	SUWA et al.	355	71	
ND	BR 4,241,389	12/1980	HEIMER	362	297	
ND	CR 3,770,340	11/1973	CRONIN et al.	350	162	
ND	DR 4,291,938	09/1981	WAGNER	350	91	
ND	ER 4,936,665	06/1990	WHITNEY	350	451	

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	Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
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ND	FR WO 92/03842	03/1992	PCT	Shiraishi	X		X	
ND	GR 61-91662 (A)	05/1986	Japan	Horiuchi	X		X	
ND	HR 0 011 709 A2	10/1979	European	Wagner		X		X
ND	IR EP0 747772 A1	04/1996	European	Wangler et al.		X		X
	JR							

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ND	KR	Revocation of EP-B-0500393 to Canon Kabushiki Kaisha - May 26, 2000						
ND	LR	Cronin et al., "Dynamic Coherent Optical System," Optical Engineering, Mar/Apr 1973, Vol. 12, No. 2, pp. 50-55.						
ND	MR	Reynolds, "A concept for a High Resolution Optical Lithographic System for Producing One-Half Micron Linewidths," Optical Microlithography V (1986) SPIE Vol. 633, pp. 228-238.						
ND	NR	Yang et al., "Effect of central obscuration on image formation in projection lithography," SPIE Vol. 1264 Optical/Laser Microlithography III (1990), pp. 477-485.						
ND	OR	Pol et al., "Excimer laser based lithography: a deep-ultraviolet wafer stepper for VLSI processing," Optical Engineering, April 1987, Vol. 26, No. 4, pp. 311-318.						
ND	PR	Berry, "Pattern recognition automatic fine alignment," reprinted from Optical Microlithography - Technology for the Mid-1980s, Proc. SPIE Vo. 334, pp. 10-16 (1982)						
ND	QR	Fehrs et al., "Illuminator Modification of an Optical Aligner," KTI Microelectronics Seminar, Proceedings, Nov. 6-7, 1989, San Diego, CA. pp. 217-230.						

Examiner

D. J. Chacko Davis

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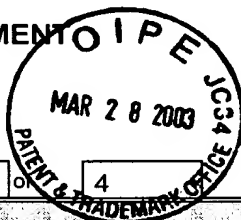
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Examiner's Initials*		Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
<i>PD</i>	AR	5,598,250	01/1997	BAE	355	67	—
<i>PD</i>	BR	6,452,662 B1	09/2002	MULKENS et al.	355	67	—
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							Enclosed	No	Enclose	No
PD	OR	0 564 264 A1	10/1993	EPO	Shiozawa et al.		X		X	
PD	PR	DE 4421053 A1	12/1995	Germany	Wangler			X		X
PD	QR	EP 0794 462A2	09/1997	EPO	Poschenrieder et al.		X		X	
	RR									
	SR									
	TR									
	UR									

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

<i>PD</i>	VR	Taiwanese Patent Office Search Report re: Taiwan patent Appl. No. 88105528 dated February 11, 2000			
<i>PD</i>	WR	European Search Report re: EP 99 302613, dated July 13, 2001			
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